Abstract Submitted for the DAMOP10 Meeting of The American Physical Society

Subwavelength Optical Microscopy in Far-Field¹ QINGQING SUN, Texas A&M University, MOHAMMAD AL-AMRI, King Abdul-Aziz City for Science and Technology, MARLAN SCULLY, Texas A&M University, Princeton University, SUHAIL ZUBAIRY, Texas A&M University — We present a complete procedure for subwavelenth optical microscopy. The identical atoms are distributed on a plane disk and shined with a standing wave. We rotate the disk to different angles and record the resonant fluorescence spectra in far-field, from which we can obtain their distance and location information. This procedure also works for atomic separation above one wavelength and so provides a seamless microscopy.

¹This work is supported by a grant from the King Abdul Aziz City for Science and Technology (KACST).

Date submitted: 22 Jan 2010 Electronic form version 1.4